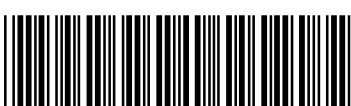


Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10706445	SHINKAI ET AL.
	Examiner tWendimagegn, Girumsew	Art Unit 2621

SEARCHED

Class	Subclass	Date	Examiner
386	52	4/24/2009	gw
725	115	4/24/2009	gw
725	93	4/24/2009	gw
725	145	4/24/2009	gw

SEARCH NOTES

Search Notes	Date	Examiner
US-PGPUB;USPAT;USOCR;EPO;JPO;DERWENT;IBM_TDB	4/24/2009	gw
Inventor(s) search	4/24/2009	gw
NPL: google(metadata WITH editing)	6/22/2007	gw
Consulted Thai Tran	4/22/2009	gw

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
386	52	4/24/2009	gw
725	115	4/24/2009	gw
725	93	4/24/2009	gw
725	145	4/24/2009	gw

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